Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/887,816	HOENE ET AL.	
Examiner	Art Unit	
Shin-Hon Chen	2131	

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Class	Subclass	Date	Examiner
713	188	10/14/2005	S.C.
726	22-25	10/14/2005	S.C.
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